

DATA SHEET

SURFACE MOUNT MULTILAYER CERAMIC CAPACITORS

Automotive grade HiCap X7R

6.3 V TO 100 V I μF to 10 μF RoHS compliant & Halogen Free



YAGEO



6.3 V to 100 V

SCOPE

This specification describes Automotive grade X7R series chip capacitors with lead-free terminations and used for automotive equipments.

<u>APPLICATIONS</u>

All general purpose applications under normal operation and usage conditions for automotive equipments.

FEATURES

- · AEC-Q200 qualified
- MSL class: MSL I
- · AC series soldering is compliant with J-STD-020D
- · High component and equipment reliability
- The capacitors are 100% performed by automatic optical inspection prior to taping.

ORDERING INFORMATION - GLOBAL PART NUMBER

All part numbers are identified by the series, size, tolerance, TC material, packing style, voltage, process code, termination and capacitance value.

GLOBAL PART NUMBER

AC XXXX X X XXX X B X XXX

(1) (2) (3) (4) (5) (6) (7)

(I) SIZE – INCH BASED (METRIC)

0201 (0603) / 0402 (1005) / 0603 (1608) / 0805 (2012) / 1206 (3216)/ 1210 (3225) /1812 (4532)

(2) TOLERANCE

 $| = \pm 5\%$

 $K = \pm 10\%$

 $M = \pm 20\%$

Capacitance tolerance ±5% doesn't available for X7R full product range, please contact local sales before order

(3) PACKING STYLE (SEE TABLE. 9 FOR DETAIL)

R = Paper/PE taping reel; Reel 7 inch

K = Blister taping reel; Reel 7 inch

P = Paper/PE taping reel; Reel 13 inch

F = Blister taping reel; Reel 13 inch

(4) TC MATERIAL

X7R

(5) RATED VOLTAGE

 $4 = 4 \ \lor$

5 = 6.3 V

6 = 10 V

7 = 16 V

8 = 25 V

G = 35 V

9 = 50 V

0 = 100 V

(6) PROCESS

B = X7R

(7) CAPACITANCE VALUE

2 significant digits + number of zeros

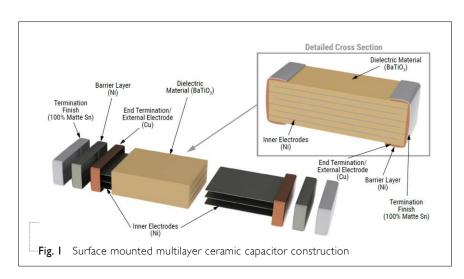
The 3rd digit signifies the multiplying factor, and letter R is decimal point

Example: $121 = 12 \times 10^{1} = 120 \text{ pF}$



The capacitor consists of a rectangular block of ceramic dielectric in which a number of interleaved metal electrodes are contained. This structure gives rise to a high capacitance per unit volume.

The inner electrodes are connected to the two end terminations and finally covered with a layer of plated tin (Matte Sn). The terminations are leadfree. A cross section of the structure is shown in Fig.I.

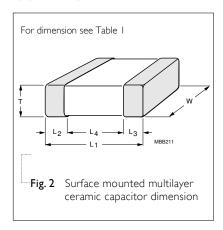


DIMENSION

Table I For outlines see fig. 2

TVDF	l (mm)	\ \ / (~~~)	T (MM)	L ₂ / L ₃ (mm)	L ₄ (mm)
TYPE	L _I (mm)	W (mm)	T (MM)	min.	max.	min.
0201	0.6 ±0.03	0.3±0.03	0.3±0.03	0.10	0.20	0.20
0402	1.0 ±0.05	0.5 ±0.05	0.5 ±0.05	0.15	0.35	0.30
0603	1.6 ±0.10	0.8 ±0.10	0.8 ±0.10	0.20	0.50	0.60
	20.10.10	125 1010	0.6 ±0.10			
0805	2.0 ±0.10	1.25 ±0.10	0.85 ±0.10	0.25	0.75	0.70
	2.0 ±0.20	1.25 ±0.20	1.25 ±0.20			
	22 .015	14.015	0.6 ±0.10			
	3.2 ±0.15	1.6 ±0.15	0.85 ±0.10			
1204			1.15 ± 0.10	0.05	0.75	1.50
1206	3.2 ±0.30	1.6 ±0.20	1.25 ±0.20	0.25	0.75	1.50
			1.6 ±0.20			
	3.2 ±0.30	1.6 ±0.30	1.6 ±0.30			
	22 +020	25.4020	0.85 ±0.10			1.50
	3.2 ±0.20	2.5 ±0.20	1.25 ±0.20			
1210	22 1020	2 - 10 20	1.6 ±0.20	0.25	0.75	
	3.2 ±0.30	2.5 ±0.20	2.0 ±0.20			
	3.2 ±0.40	2.5 ±0.30	2.5 ±0.20			
1808	4.5 ±0.40	2.0 ±0.30	1.25 ±0.20	0.25	0.75	2.20
			0.85 ±0.10			2.20
1812	4.5 ±0.40	3.2 ±0.30	1.25 ±0.20	0.25	0.75	
			1.6 ±0.20			

OUTLINES





CAPACITANCE RANGE & THICKNESS FOR X7R

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ĺ	Table 2	Sizes from	n 0603 to 08	805							
	CAP.	0603				0805					
		6.3V	10V	16 V	25 V	6.3 V	10 V	16 V	25 V	35 V	50 V
	ΙμF	0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1		1.25±0.2	1.25±0.2	1.25±0.2		1.25±0.2
	2.2 uF						1.25±0.2	1.25±0.2	1.25±0.2	1.25±0.2	
	4.7 uF						1.25±0.2	1.25±0.2			
	10 uF					1.25±0.2					

	Table 3	Sizes 120	6				
C	AP.	1206					
		6.3 V	10V	16V	25V	50 V	100 V
	ΙμF		1.15±0.10	1.15±0.10	1.60±0.2	1.60±0.2	1.60±0.2
	2.2 μF			1.60±0.2	1.60±0.2	1.60±0.2	1.60±0.2
	4.7 uF	1.60±0.2	1.60±0.2	1.60±0.2			
	10 uF						

Table 4	Sizes 12	10 to 1812			
CAP.	1210			1812	
	25 V	50V	100 V	50V	100V
ΙμF	1.25±0.20	1.25±0.20	2.0±0.2	1.60±0.2	1.60±0.2
2.2 µF		2.0±0.2	2.0±0.2		
4.7 µF	2.5±0.2	2.5±0.2			

NOTE

- I. Values in shaded cells indicate thickness class in mm
- 2. Capacitance value of non E3 series is on request

ELECTRICAL CHARACTERISTICS

YAGEC

X7R DIELECTRIC CAPACITORS; NI/SIN TERMINATIONS

Unless otherwise specified, all test and measurements shall be made under standard atmospheric conditions for testing as given in 5.3 of IEC 60068-1:

- Temperature: 15 °C to 35 °C - Relative humidity: 25% to 75% - Air pressure: 86 kPa to 106 kPa

Before the measurements are made, the capacitor shall be stored at the measuring temperature for a time sufficient to allow the entire capacitor to reach this temperature.

The period as prescribed for recovery at the end of a test is normally sufficient for this purpose.

DESCRIPTION Table 5	VALUE
Capacitance tolerance	150((1) 1100(1200(
X7R	±5% ⁽¹⁾ , ±10%, ±20%
Maximum capacitance change as a function of temperature	
(temperature characteristic/coefficient):	
X7R	±15%
Operating temperature range:	
X7R	-55 °C to +125 °C

NOTE

1. Capacitance tolerance ±5% doesn't available for X7R full product range, please contact local sales force before order

RATED VOLTAGE AND CAPACITANCE

Table 6

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lable 6	DATED				
SIZE	RATED VOLTAGE	CAPACITANCE	D.F.	RC @ 25 °C	RC @ 125 °C
CODE	(V)	(μ F)		(Ω· F)	(Ω· F)
	6.3	1.0	5.0%	500	50
0603	10	1.0	5.0%	500	50
0603	16	0.1	7.5%	100	5
	25	1.0	7.5%	100	5
	10	1.0	5.0%	500	50
	16	1.0	5.0%	500	50
	25	0.1	5.0%	500	50
	50	1.0	5.0%	500	10
	10	2.2	5.0%	100	10
0805	16	2.2	5.0%	500	50
	25	2.2	5.0%	500	50
	35	2.2	5.0%	500	50
	10	4.7	10.0%	100	10
	16	4.7	10.0%	100	10
	6.3	10.0	10.0%	100	10
	10	1.0	3.5%	500	10
	25	0.1	3.5%	500	10
	50	0.1	5.0%	500	10
	100	1.0	5.0%	500	10
	16	2.2	5.0%	500	50
1206	25	2.2	5.0%	500	50
	50	2.2	5.0%	500	10
	100	2.2	5.0%	500	10
	6.3	4.7	10.0%	50	5
	10	4.7	10.0%	50	5
	16	4.7	10.0%	50	5
	25	0.1	2.5%	500	50
	50	0.1	2.5%	500	50
	100	1.0	5.0%	500	50
1210	50	2.2	5.0%	500	50
	100	2.2	5.0%	500	50
	25	4.7	10.0%	500	10
	50	4.7	10.0%	500	10
1013	50	1.0	2.5%	500	50
1812	100	1.0	2.5%	500	50







6.3 V to 100 V

SOLDERING RECOMMENDATION

Table 7

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METHOD	0201	0402	0603
SOLDERING	SIZE		

METHOD	0201	0402	0603	0805	1206	≥ 1210
Reflow	Reflow only	≥ 0.1 µF	≥ 1.0 µF	≥ 2.2 µF	≥ 4.7 µF	Reflow only
Reflow/Wave		< 0.1 µF	< 1.0 µF	< 2.2 µF	< 4.7 µF	

SOLDERING CONDITIONS

The lead free MLCCs are able to stand the reflow soldering conditions as below:

- Temperature: above 220 °C
- Endurance: 95 to 120 seconds
- Cycles: 3 times

The test of "soldering heat resistance" is carried out in accordance with the schedule of "MIL-STD-202G-method 210F", "The robust construction of chip capacitors allows them to be completely immersed in a solder bath of 260 °C for 10 seconds". Therefore, it is possible to mount MLCCs on one side of a PCB and other discrete components on the reverse (mixed PCBs). Surface Mount Capacitors are tested for solderability at 245 °C during 2 seconds. The test condition for no leaching is 260°C for 30 seconds.

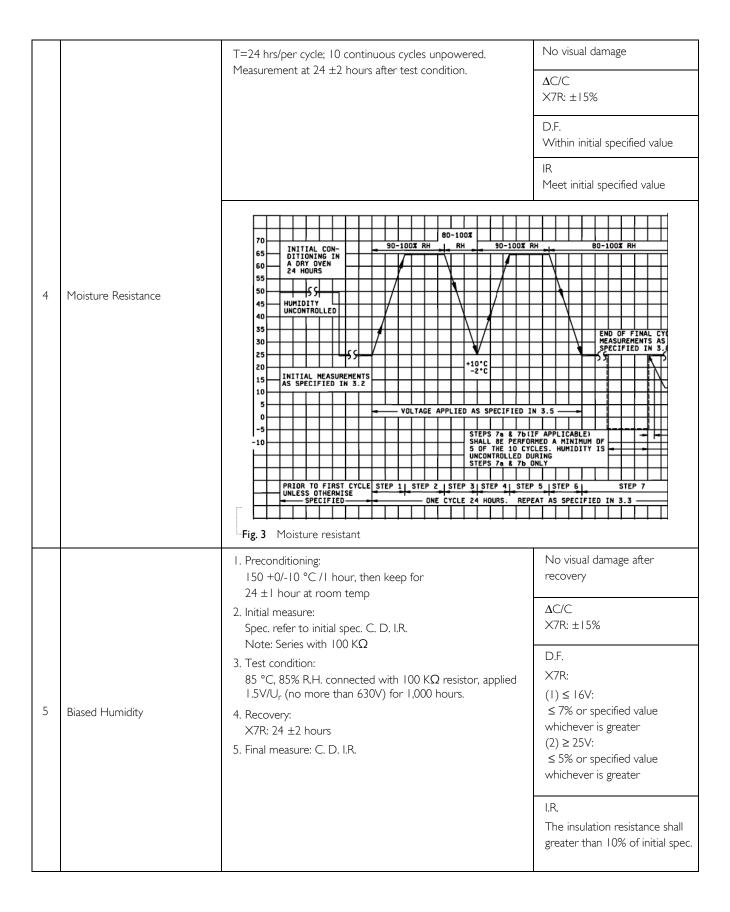
TESTS AND REQUIREMENTS

Table 8 Test procedures and requirements

NO	AEC-Q200 TEST	TEST METHOD	REQUIREMENTS
	High Temperature Exposure	Unpowered; 1000hours @ T=150 °C Measurement at 24±2 hours after test conclusion.	No visual damage
		Treasurement at 2122 hours after test contribution.	ΔC/C X7R: Within ±10%
I			D.F.: within initial specified value
			IR: within initial specified value
	Temperature Cycling	Preconditioning; I50 +0/–I0 °C for I hour, then keep for	No visual damage
2		24 ±1 hours at room temperature	ΔC/C X7R: ±10%
2		30 minutes at lower category temperature 30 minutes at upper category temperature	D.F. meet initial specified value
		Recovery time 24 ±2 hours	IR meet initial specified value
3	Destructive Physical Analysis	Electrical test not required.	



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		I. Preconditioning:	No visual damage
		150 +0/-10 °C /1 hour, then keep for	ΔC/C
		24 ±1 hour at room temp	X7R: ±15%
		2. Initial measure:	
		Spec: refer to initial spec C, D, IR	D.F.
		3. Endurance test:	Less than 200% of initial spec.
		Temperature: 125 °C	'
6	High Temperature	Specified stress voltage applied for 1,000 hours:	IR
	Operational Life	Applied 150% x Ur.	The insulation resistance shall
		4. Recovery time: 24 ±2 hours	be greater than 10% of initial
		5. Final measure: C, D, IR	spec.
		Note: If the capacitance value is less than the minimum value	·
		permitted, then after the other measurements have been	
		made the capacitor shall be preconditioned according to	
		"IEC 60384 4.1" and then the requirement shall be met.	
7	External Visual	Any applicable method using × 10 magnification	In accordance with specification
		Verify physical dimensions to the applicable device	In accordance with specification
8	Physical Dimension	specification.	in deed, edined man specimedia.
		Three shocks in each direction shall be applied along the three	ΔC/C
		mutually perpendicular axes of the test specimen	X7R: ±10%
		(18 shocks)	D.F.
9	Mechanical Shock	Peak value: 1,500 g's	Within initial specified value
		Duration: 0.5 ms	vvidilir iriidai specified valde
		Velocity change: 15.4 ft/s	IR
		Waveform: Half-sin	Within initial specified value
		5 g's for 20 minutes, 12 cycles each of 3 orientations.	ΔC/C
		Test from 10-2000 Hz.	X7R: ±10%
10	Vibration	1 000 11 011 1 10 2000 1 12	D.F: meet initial specified value
			IR meet initial specified value
		Precondition: I50 +0/–I0 $^{\circ}$ C for I hour, then keep for 24 \pm I	Dissolution of the end face
		hours at room temperature	plating shall not exceed 25% of the length of the edge
		Preheating: for size ≤ 1206: 120 °C to 150 °C for 1 minute	concerned
		Preheating: for size > 1206: 100 °C to 120 °C for 1 minute and	
11	Resistance to Soldering Heat	170 °C to 200 °C for∣minute	ΔC/C
		Solder bath temperature: 260±5 °C	X7R: ±10%
		Dipping time: 10±0.5 seconds	D.F. within initial specified value
		Recovery time: 24±2 hours	IR within initial specified value
			·

		I. Preconditioning: I50 +0/-I0 °C /I hour, then keep for 24±1 hour at room	No visual damage
		temp 2. Initial measure: Spec: refer to initial spec C, D, IR	ΔC/C X7R: ±15%
12	Thermal Shock	3. Rapid change of temperature test: -55 °C to +125 °C; 300 cycles	D.F: meet initial specified value
		I5 minutes at -55°C; I5 minutes at I25°C 4. Recovery time: X7R 24±2 hours 5. Final measure: C, D, IR	IR meet initial specified value
		Per AEC-Q200-002	A component passes a voltage level if all components stressed at that voltage level pass.
13	ESD		B kV DC 12 kV AD 25 kV AD FAIL PASS 16 kV AD 25
14	Solderability	 Preheat at 155°C for 4 hours. After preheating, immerse the capacitor in a solution of ethanol and rosin (25% rosin in weight proportion). Immerse in eutectic solder solution for 5+0/-0.5 seconds at 235±5°C. Should be placed into steam aging for 8 hours±15 minutes. After preheating, immerse the capacitor in a solution of ethanol and rosin (25% rosin in weight proportion). Immerse in eutectic solder solution for 5+0/-0.5 seconds at 235±5°C. Should be placed into steam aging for 8 hours±15 minutes. After preheating, immerse the capacitor in a solution of Ethanol and rosin (25% rosin in weight proportion). Immerse in eutectic solder solution for 120±5 seconds at 260±5°C. 	The solder should cover over 95% of the critical area of each termination.

		Capacitance	X7R: At 25 °C, 24 hours after annealing $f = 1 \pm 0.1$ KHz, measuring at voltage 1 ± 0.2 V _{ms} at 25 °C	Within specified tolerance
		Dissipation Factor (D.F.)	X7R: At 25 °C, 24 hours after annealing $f = 1 \pm 0.1$ KHz, measuring at voltage 1 ± 0.2 V _{ms} at 25 °C	In accordance with specification on Table 6
		Insulation Resistance (I.R.)	At U _r (DC) for I minute	In accordance with specification on Table 6
			Capacitance shall be measured by the steps shown in the following table. The capacitance change should be measured after 5 min at each specified temperature stage.	ΔC/C X7R: ±15% X7S: ± 22%
			Step Temperature(°C)	
	Electrical		a 25±2	
15	Characterization		b Lower temperature±3°C	
		.	c 25±2	
		Temperature coefficient	d Upper Temperature±2°C	
		COCINCICITE	e 25±2	
			X7R Capacitance Change shall be calculated from the formula as below $\Delta C = \frac{C2 - C1}{C1} \times 100\%$ C1: Capacitance at step c C2: Capacitance at step b or d	
		Voltage Proof	 Specified stress voltage applied for 1~5 seconds Ur ≤ 100 V: series applied 2.5 Ur Charge/Discharge current is less than 50 mA 	No breakdown or flashover

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		Part mounted on a 100mm × 40mm FR4 PCB board, which is	No visu	al dama	age		
		1.6±0.2 mm thick and has a layer-thickness 35μm±10 μm. Part should be mounted using the following soldering reflow profile. Conditions:	ΔC/C X7R: ±10%				
		Bending 2 mm at a rate of 1 mm/s, radius jig 340 mm		Dimen	sion(m	m)	
		Test Substrate:	Туре	а	b	С	
		. b .	0201	0.3	0.9	0.3	
16	Board Flex	Φ4.5 YNSC147	0402	0.4	1.5	0.5	
			0603	1.0	3.0	1.2	
			0805	1.2	4.0	1.65	
		<u>a</u> /	1206	2.2	5.0	1.65	
		100	1210	2.2	5.0	2.0	
		unit: mm	1808	3.5	7.0	3.7	
17	Terminal Strength	With the component mounted on a PCB obtained with the device to be tested, apply a 17.7N (1.8Kg) force to the side of a device being tested. This force shall be applied for 60+1 seconds. Also the force shall be applied gradually as not to apply a shock to the component being tested. * Apply 2N force for 0402 size. * Apply 1N force for 0201 size.	Magnific may be inspecti- integrity termina junction Before, test, the with all stated in	employ on of the of the ls and b during a during a device electric	ved for ne med device body/te and afte shall co al requi	nanical body, rminal er the omply irements	
18	Beam Load Test	Place the part in the beam load fixture. Apply a force until the part breaks or the minimum acceptable force level required in the user specification(s) is attained.					

Surface-Mount Ceramic Multilayer Capacitors | Automotive Grade HiCap | X7R | 6.3 V to 100 V

THICKNESS CLASSES AND PACKING QUANTITY

Table 9

	THEKNIESS	DA CKII	NG CODE			QUANTIT	Y PER REEL	
SIZE CODE	THICKNESS	PACKII	NG CODE	TAPE WIDTH	Ø180 M	M / 7 INCH	Ø330 M	M / 13 INCH
	CLASSIFICATION	7 INCH	13 INCH		Paper	Blister	Paper	Blister
0201	0.3 ±0.03 mm	R	Р	8 mm	15,000		50,000	
0402	0.5 ±0.05 mm	R	Р	8 mm	10,000		50,000	
0603	0.8 ±0.1 mm	R	Р	8 mm	4,000		15,000	
	0.6 ±0.1 mm	R	Р	8 mm	4,000		20,000	
0805	0.85 ±0.1 mm	R	Р	8 mm	4,000		15,000	
	1.25 ±0.2 mm	K	F	8 mm		3,000		10,000
	0.6 ±0.1 mm	R	Р	8 mm	4,000		20,000	
	0.85 ±0.1 mm	R	Р	8 mm	4,000		15,000	
1206	1.0/1.15 ±0.1 mm	K	F	8 mm		3,000		10,000
	1.25 ±0.2 mm	K	F	8 mm		3,000		10,000
	1.60 ±0.2 mm	K	F	8 mm		2,000		8,000
	0.85 ±0.1 mm	K	F	8 mm		4,000		10,000
	1.15 ±0.1 mm	K	F	8 mm		3,000		10,000
1210	1.25 ±0.2 mm	K	F	8 mm		3,000		10,000
	2.0 ±0.2 mm	K		8 mm		2,000		
	2.5 ±0.2 mm	K		8 mm		1,000		
	0.6 / 0.85±0.1 mm	K		I2 mm		2,000		
1012	1.15±0.1 mm	K		I2 mm		1,000		
1812	1.25±0.2 mm	K		I2 mm		1,000		
	1.6 ±0.2 mm	K		I2 mm		2,000		

PAPER/PE TAPE SPECIFICATION

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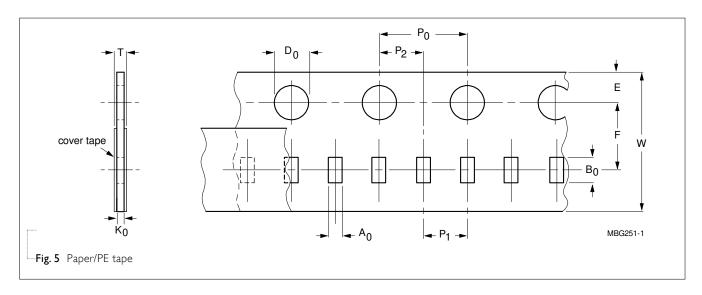


Table 10 Dimensions of paper/PE tape for relevant chip size; see Fig.5

SIZE	SYMBOL Unit: r											
CODE	A0	В0	W	E	F	P0 (I)	PI	P2	ØD0	K0	Т	
0201	0.39 ± 0.06	0.70 ± 0.06	8.0 ± 0.20	1.75 ± 0.1	3.50 ± 0.05	4.0 ± 0.05	2.0 ± 0.05	2.0 ± 0.05	1.55 ± 0.03	0.38 ± 0.05	(0.47 / 0.55)±0.10	
0402	0.70 ± 0.15	1.21 ± 0.12	8.0 ± 0.20	1.75 ± 0.1	3.50 ± 0.05	4.0 ± 0.05	2.0 ± 0.05	2.0 ± 0.05	1.50 +0.1 /-0	(0.75 / 0.60)±0.10	(0.85 / 0.70)±0.10	
0603	1.05 ± 0.14	1.86 ± 0.13	8.0 ± 0.20	1.75 ± 0.1	3.50 ± 0.05	4.0 ± 0.10	4.0 ± 0.10	2.0 ± 0.05	1.50 +0.1 /-0	(1.05 / 0.95 / 0.75)±0.10	(1.15 / 1.05 / 0.85)±0.10	
0805	1.50 ± 0.15	2.26 ± 0.20	8.0 ± 0.20	1.75 ± 0.1	3.50 ± 0.05	4.0 ± 0.10	4.0 ± 0.10	2.0 ± 0.05	1.50 +0.1 /-0	(1.05 / 0.95 / 0.75)±0.10	(1.15 / 1.05 / 0.85)±0.10	
1206	1.90 ± 0.15	3.50 ± 0.20	8.0 ± 0.20	1.75 ± 0.1	3.50 ± 0.05	4.0 ± 0.10	4.0 ± 0.10	2.0 ± 0.05	1.50 +0.1 /-0	(0.95 / 0.75)±0.10	(1.05 / 0.85)± 0.10	

NOTE

 $1.P_0$ pitch tolerance over any 10 pitches is $\pm 0.2 \ mm$

BLISTER TAPE SPECIFICATION

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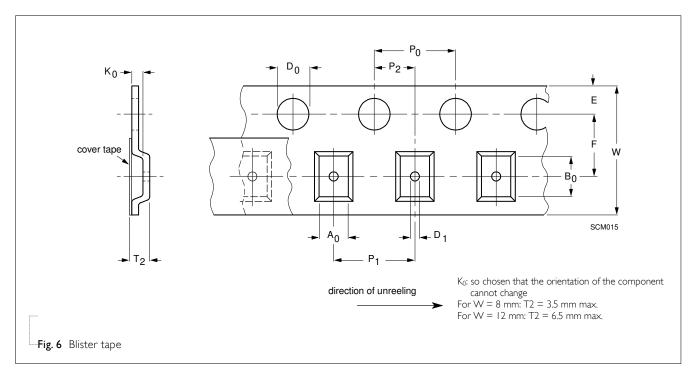


Table II Dimensions of blister tape for relevant chip size; see Fig.6

	SYMBOL											Un	it: mm			
SIZE CODE	A ₀		B ₀		K ₀		W	E	F	$ØD_0$	ØD _I	P ₀ (2)	P _I	P ₂		T2
	Min.	Max.	Min.	Max.	Min.	Max.					Min.				Min.	Max.
0805	1.29	1.65	2.09	2.60	1.25	1.62	8.I ±0.20	1.75 ±0.1	3.5 ±0.05	1.5 +0.1/-0.0	1 +0.1/-0.0	4.0 ±0.10	4.0 ±0.10	2.0 ±0.05	1.30	1.67
1206	1.65	2.12	3.30	3.75	1.22	2.15	8.I ±0.20	1.75 ±0.1	3.5 ±0.05	1.5 +0.1/-0.0	1 +0.1/-0.0	4.0 ±0.10	4.0 ±0.10	2.0 ±0.05	1.27	2.20
1210	2.55	3.02	3.31	3.88	0.97	2.92	8.I ±0.20	1.75 ±0.1	3.5 ±0.05	1.5 +0.1/-0.0	1 +0.1/-0.0	4.0 ±0.10	4.0 ±0.10	2.0 ±0.05	1.02	2.97
1808	2.05	2.55	4.80	5.45	1.30	2.45	12.1 ±0.20	1.75 ±0.1	5.5 ±0.05	1.5 +0.1/-0.0	1.5 +0.1/-0.0	4.0 ±0.10	4.0 ±0.10	2.0 ±0.05	1.35	2.50
1812	3.35	3.75	4.70	5.33	0.70	2.40	12.1 ±0.20	1.75 ±0.1	5.5 ±0.05	1.5 +0.1/-0.0	1.5 +0.1/-0.0	4.0 ±0.10	8.0 ±0.10	2.0 ±0.05	0.75	2.45

NOTE

- I. Typical capacitor displacement in pocket
- 2. P_0 pitch tolerance over any 10 pitches is ± 0.2 mm





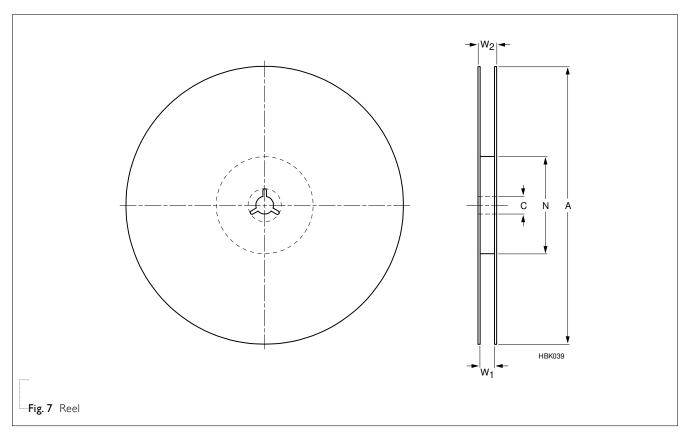


Table 12 Reel dimensions; see Fig.7

	SYMBOL									
TAPE WIDTH	A	N	С	Wı	W _{2max} .					
8 (Ø178 mm/7")	178 ±1.0	60 ±1.0	13 +0.50/-0.20	9.4 ±1.5	14.4					
8 (Ø330 mm/13")	330 ±1.0	100 ±1.0	13 +0.50/-0.20	9.0 ±0.2	14.4					
12 (Ø178 mm/7")	178 ±1.0	60 ±1.0	13 +0.50/-0.20	13.4 ±1.5	18.4					

PROPERTIES OF REEL

Material: polystyrene

Surface resistance: <1010 X/sq.



SOLDER REPAIRS

Conventional solder repairs are carried out with a soldering iron as shown as Tab. 13. The tip of the soldering iron should not directly touch the chip component to avoid thermal shock on the interface between termination and body during mounting, repairing or de-mounting processes. Ensure the termination solder has melted before removing the chip component.

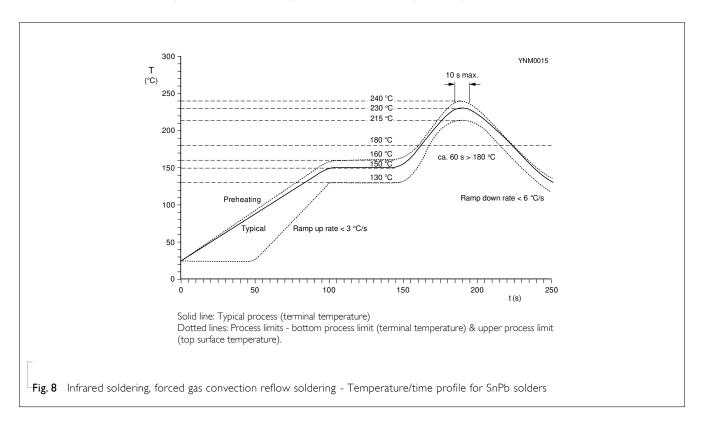
Table 13 Recommended soldering iron condition

SIZE	Temp(°C)	DURATION (SEC.)	PREHEATING TEMP(°C)	ATMOSPHERE
0201/0402/0603/0805/1206	350 max.	3 max.	150 min.	air
1210/1808/1812/2220	280 max.	3 max.	150 min.	air

SOLDERING CONDITIONS

For normal use the capacitors may be mounted on printed-circuit boards or ceramic substrates by applying wave soldering, reflow soldering or conductive adhesive in accordance with IEC 61760-1 (Standard method for the specification of surface mounting components). For advised soldering profiles see Figs 8, 9, 10.

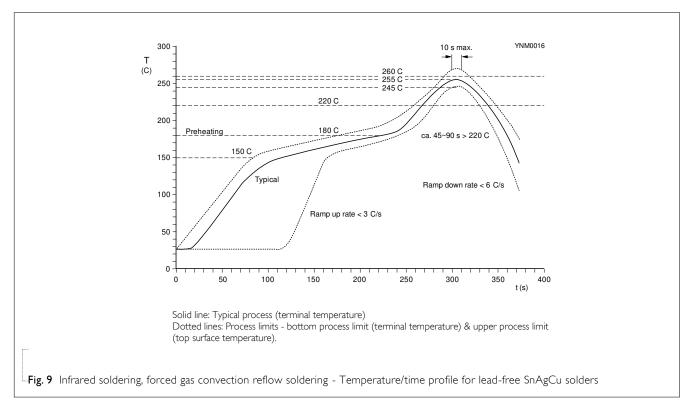
An improper combination of soldering, substrate and chip size can lead to a damaging of the component. The risk increases with the chip size and with temperature fluctuations (>100 °C).

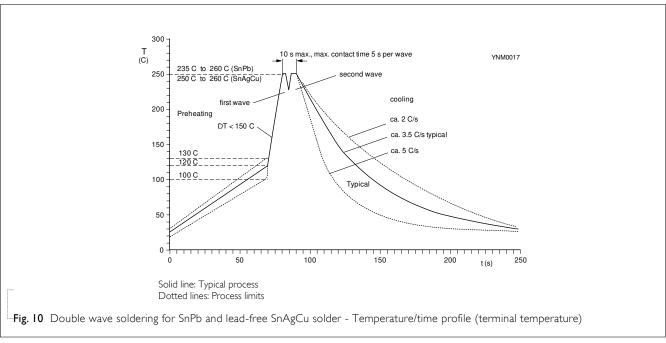




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FOOTPRINT DIMENSIONS

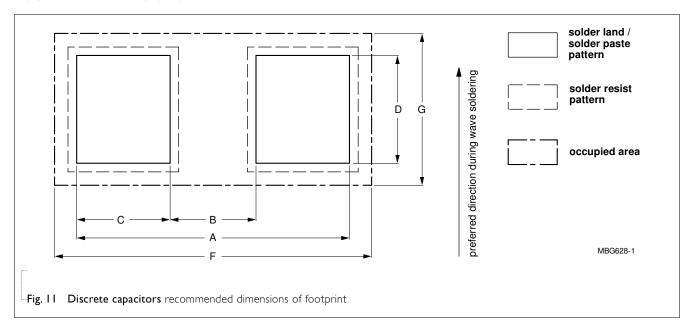


Table 14 Reflow soldering; for footprint dimensions see Fig. I I

SIZE	FOOTPRIN	Unit: mm					
CODE	Α	В	С	D	F	G	Processing remarks
0201	0.8 ±0.20	0.25 ±0.05	0.28 ±0.07	0.3 ±0.10			_
0402	1.5 ±0.15	0.5 ±0.15	0.5 ±0.15	0.5 ±0.15	1.75 ±0.15	0.95 ±0.15	_
0603	2.3 ±0.15	0.7 ±0.15	0.8 ±0.15	0.9 ±0.15	2.7 ±0.15	1.5 ±0.15	_
0603	2.3 ±0.25	0.5 ±0.25	0.9 ±0.25	0.9 ±0.25	2.7 ±0.25	1.5 ±0.25	IR or hot plate soldering
0805	2.8 ±0.25	0.9 ±0.25	0.95 ±0.25	1.4 ±0.25	3.2 ±0.25	2.1 ±0.25	_
1206	4.0 ±0.25	2.0 ±0.25	1.0 ±0.25	1.8 ±0.25	4.4 ±0.25	2.5 ±0.25	_
1210	4.0 ±0.25	2.0 ±0.25	1.0 ±0.25	2.7 ±0.25	4.4 ±0.25	3.4 ±0.25	
1808	5.4 ±0.25	3.3 ±0.25	1.05 ±0.25	2.3 ±0.25	5.8 ±0.25	2.9 ±0.25	_
1812	5.4 ±0.25	3.3 ±0.25	1.05 ±0.25	3.5 ±0.25	5.8 ±0.25	4.1 ±0.25	Ceramic substrate only
2220	6.6 ±0.25	4.5 ±0.25	1.05 ±0.25	5.3 ±0.25	7.0 ±0.25	5.9 ±0.25	



Product specification 20

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6.3 V to 100 V

REVISION HISTORY

REVISION	DATE	CHANGE NOTIFICATION	DESCRIPTION
Version 0	Jun. 10, 2022	-	- New

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Surface-Mount Ceramic Multilayer Capacitors

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